TRF1208-EP Enhanced Product, Near-DC to 11GHz, Fully Differential RF Amplifier

1 Features

- Vendor item drawing number: VID V62/25645
- High reliability enhanced product
  - Controlled baseline
  - One assembly and test site
  - One fabrication site
  - Extended product life cycle
  - Product traceability
  - Lead-free construction
  - Extended temperature range: –55°C to +125°C
- Excellent performance driving RF ADCs
- Fixed power gain of 16dB in single-ended-to-differential mode
- Bandwidth: 11GHz, 3dB
- Gain flatness: 8GHz, 1dB
- OIP3: 37dBm (2GHz), 30dBm (6GHz)
- P1dB: 15dBm (2GHz), 12.5dBm (6GHz)
- NF: 6.8dB (2GHz), 7.2dB (6GHz)
- Gain and phase imbalance: ±0.3dB and ±3º
- Power-down feature
- Single-supply operation: 3.3V
- Active current: 138mA

2 Applications

- RF sampling or GSPS ADC driver
- Aerospace and defense
- Phased array radar
- Radar seeker front end
- Electronic warfare (SIGINT, ELINT)
- Military radios
- Satellite Communications (SATCOM)

3 Description

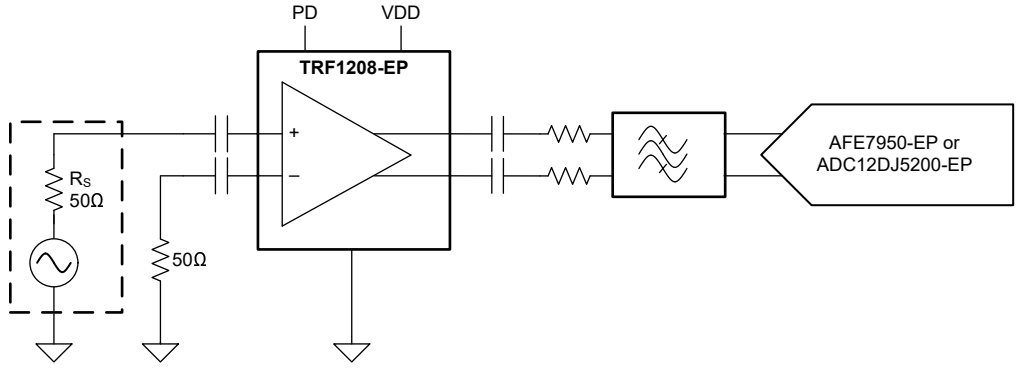
The TRF1208-EP is a very high-performance fully differential amplifier (FDA) optimized for radio-frequency (RF) applications. This device is an excellent choice for ac-coupled applications that require single-ended-to-differential conversion when driving an analog-to-digital converter (ADC) such as the high-performance AFE7950-EP or ADC12DJ5200-EP. The on-chip matching components simplify printed-circuit-board (PCB) implementation and provide the highest performance over the usable bandwidth. The device is fabricated in Texas Instruments' advanced complementary BiCMOS process and is available in a space-saving, WQFN-FCRLF package.

The TRF1208-EP operates on a single-rail supply and consumes approximately 138mA of active current. A power-down feature is available for power saving.

Package Information

PART NUMBER	PACKAGE(1)	PACKAGE SIZE(2)
TRF1208-EP	RPV (WQFN-FCRLF, 12)	2mm × 2mm

(1) For more information, see Section 10.
(2) The body size (length × width) is a nominal value and includes pins.



TRF1208-EP Driving a High-Speed ADC

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4 Pin Configuration and Functions

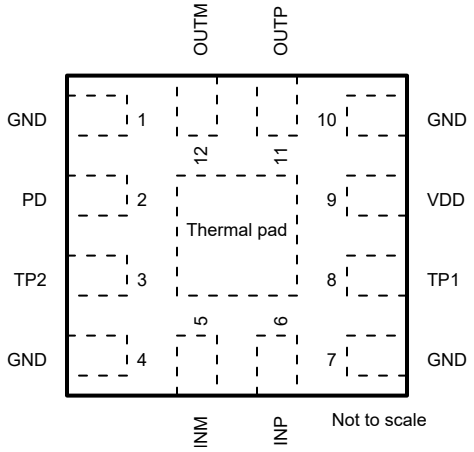


Figure 4-1. RPV Package, 12-Pin WQFN-FCRLF (Top View)

Table 4-1. Pin Functions

PIN		TYPE	DESCRIPTION
NAME	NO.		
GND	1, 4, 7, 10	Ground	Ground
INM	5	Input	Differential signal input, negative
INP	6	Input	Differential signal input, positive
OUTM	12	Output	Differential signal output, negative
OUTP	11	Output	Differential signal output, positive
PD	2	Input	Power-down signal. Supports 1.8V and 3.3V logic. 0 = Chip enabled 1 = Power down
TP1	8	—	Test pin. Short to ground.
TP2	3	—	Test pin. Short to ground.
VDD	9	Power	3.3V supply
Thermal pad	Pad	—	Thermal pad. Connect to ground on board.

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
V_{DD}	Supply voltage	–0.3	3.7	V
INP, INM	Input pin power		20(2)	dBm
V_{PD}	Power-down pin voltage	–0.3	3.7(3)	V
T_J	Junction temperature		150	°C
T_{stg}	Storage temperature	–65	150	°C

(1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
(2) When V_{DD} = 0V, maximum value is 0dBm.
(3) When V_{DD} = 0V, maximum value is 0.3V.

5.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins(1)	±1000	V
		Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002, all pins(2)	±250	

(1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{DD}	Supply voltage	3.2	3.3	3.45	V
T_A	Ambient free-air temperature	–55	25		°C
T_J	Junction temperature			125	°C

5.4 Thermal Information

THERMAL METRIC(1)		TRF1208-EP RPV (WQFN-FCRLF) 12 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	66.9	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	64.3	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	17.4	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	1.7	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	17.2	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	9.0	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

5.5 Electrical Characteristics

at T_A = 25°C, V_{DD} = 3.3V, 50Ω single-ended input, and 100Ω differential output (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
AC PERFORMANCE						
SSBW	Small-signal 3dB bandwidth	V_O = 0.1V_{PP}		11		GHz
LSBW	Large-signal 3dB bandwidth	V_O = 1V_{PP}		11		GHz
1dB BW	Bandwidth for 1dB flatness			8		GHz
S21	Power gain	f = 2GHz		16		dB
S11	Input return loss	f = 10MHz to 8GHz		–10		dB
S12	Reverse isolation	f = 2GHz		–35		dB
Imb_{GAIN}	Gain imbalance	f = 10MHz to 8GHz		± 0.3		dB
Imb_{PHASE}	Phase imbalance	f = 10MHz to 8GHz		± 3		degrees
CMRR	Common-mode rejection ratio[1]	f = 2GHz		–45		dB
HD2	Second-order harmonic distortion	f = 0.5GHz, P_O = 3dBm		–70		dBc
		f = 2GHz, P_O = 3dBm		–65		
		f = 6GHz, P_O = 3dBm		–52		
		f = 8GHz, P_O = 3dBm		–45		
HD3	Third-order harmonic distortion	f = 0.5GHz, P_O = 3dBm		–68		dBc
		f = 2GHz, P_O = 3dBm		–63		
		f = 6GHz, P_O = 3dBm		–56		
		f = 8GHz, P_O = 3dBm		–63		
IMD2	Second-order intermodulation distortion	f = 0.5GHz, P_O = –4dBm per tone (10MHz spacing)		–73		dBc
		f = 2GHz, P_O = –4dBm per tone (10MHz spacing)		–69		
		f = 6GHz, P_O = –4dBm per tone (10MHz spacing)		–56		
		f = 8GHz, P_O = –4dBm per tone (10MHz spacing)		–45		
IMD3	Third-order intermodulation distortion	f = 0.5GHz, P_O = –4dBm per tone (10MHz spacing)		–75		dBc
		f = 2GHz, P_O = –4dBm per tone (10MHz spacing)		–84		
		f = 6GHz, P_O = –4dBm per tone (10MHz spacing)		–72		
		f = 8GHz, P_O = –4dBm per tone (10MHz spacing)		–51		
OP1dB	Output 1dB compression point	f = 0.5GHz		11		dBm
		f = 2GHz		15		
		f = 6GHz		12.5		
		f = 8GHz		7.5		
OIP2	Output second-order intercept point	f = 0.5GHz, P_o = –4dBm per tone (10MHz spacing)		68		dBm
		f = 2GHz, P_o = –4dBm per tone (10MHz spacing)		63		
		f = 6GHz, P_o = –4dBm per tone (10MHz spacing)		55		
		f = 8GHz, P_o = –4dBm per tone (10MHz spacing)		42		

5.5 Electrical Characteristics (continued)

at T_A = 25°C, V_{DD} = 3.3V, 50Ω single-ended input, and 100Ω differential output (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OIP3	Output third-order intercept point	f = 0.5GHz, P_o = –4dBm per tone (10MHz spacing)		34		dBm
		f = 2GHz, P_o = –4dBm per tone (10MHz spacing)		37		
		f = 4GHz, P_o = –4dBm per tone (10MHz spacing)		34		
		f = 6GHz, P_o = –4dBm per tone (10MHz spacing)		30		
		f = 8GHz, P_o = –4dBm per tone (10MHz spacing)		21		
NF	Noise figure	f = 0.5GHz		6.5		dB
		f = 2GHz		6.8		
		f = 6GHz		7.2		
		f = 8GHz		7		
IMPEDANCE						
Z_{O-DIFF}	Differential output impedance	f = dc (internal to the device)		3		Ω
Z_{IN}	Single-ended input impedance	INM pin terminated with 50Ω		50		Ω
TRANSIENT						
V_{OMAX}	Maximum output voltage (differential)			2		V_{PP}
V_{OSAT}	Output saturated voltage level (differential)	f = 2GHz		3.9		V_{PP}
t_{REC}	Overdrive recovery time	Using a –0.5V_P input pulse of 2ns duration		0.2		ns
POWER SUPPLY						
I_{QA}	Active current	Current on V_{DD} pin, PD = 0		138		mA
I_{QPD}	Power-down quiescent current	Current on V_{DD} pin, PD = 1		7		mA
ENABLE						
V_{PDHIGH}	PD pin logic high		1.45			V
V_{PDLOW}	PD pin logic low				0.8	V
I_{PDBIAS}	PD bias current (current on PD pin)	PD = high (1.8V logic)		50	100	μA
		PD = high (3.3V logic)		200	250	
C_{PD}	PD pin capacitance			2		pF
t_{ON}	Turn-on time	50% V_{PD} to 90% RF		200		ns
t_{OFF}	Turn-off time	50% V_{PD} to 10% RF		50		ns

(1) Calculated using the formula (S21 – S31) / (S21 + S31). Port-1: INP, Port-2: OUTP, Port-3: OUTM.

5.6 Typical Characteristics

at T_A = 25°C, temperature curves specify ambient temperature, V_{DD} = 3.3V, 50Ω single-ended input, and 100Ω differential output (unless otherwise noted)

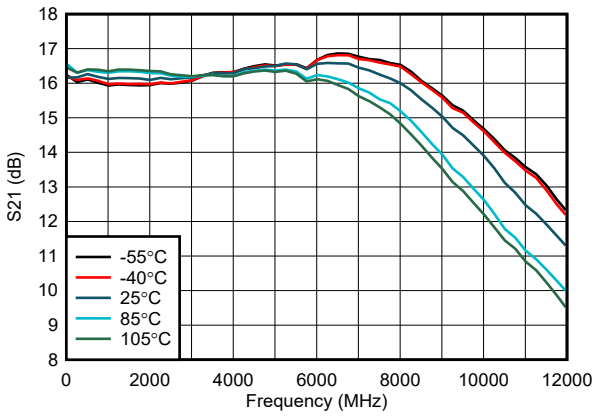


Figure 5-1. Power Gain Across Temperature

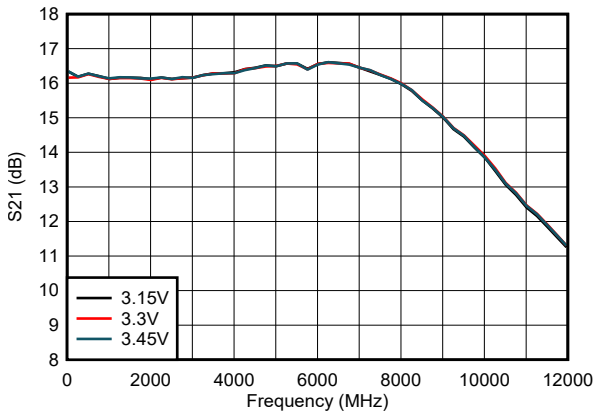


Figure 5-2. Power Gain Across V_{DD}

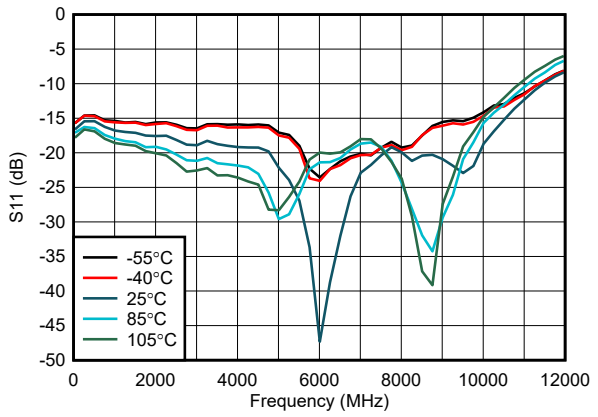


Figure 5-3. Return Loss Across Temperature

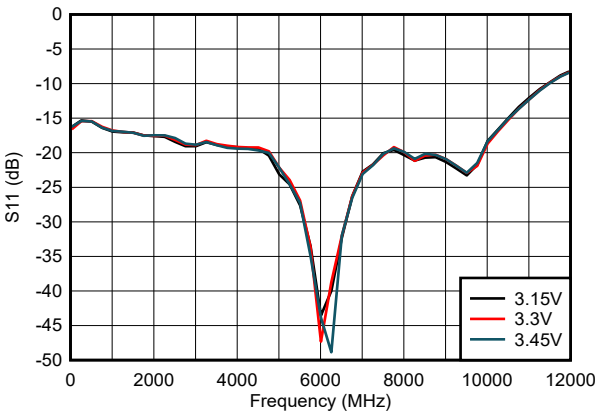


Figure 5-4. Return Loss Across V_{DD}

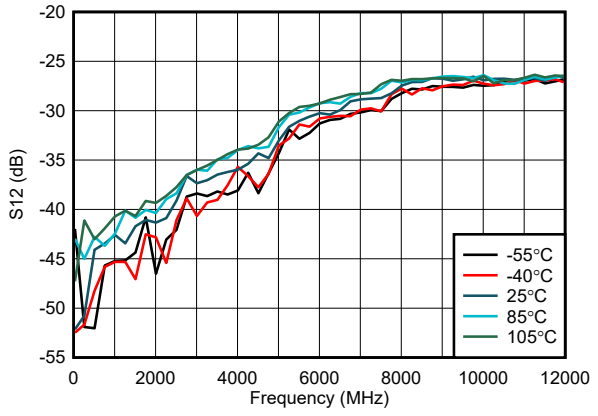


Figure 5-5. Reverse Isolation Across Temperature

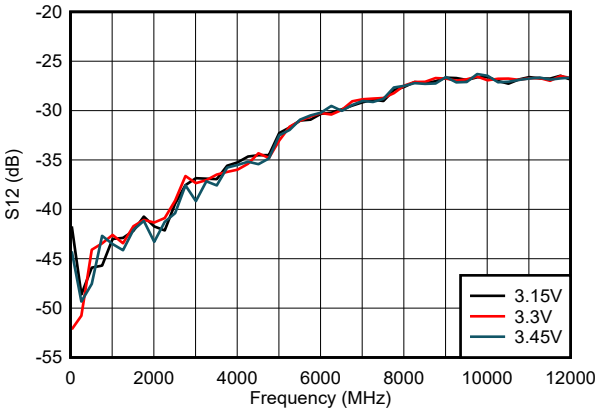
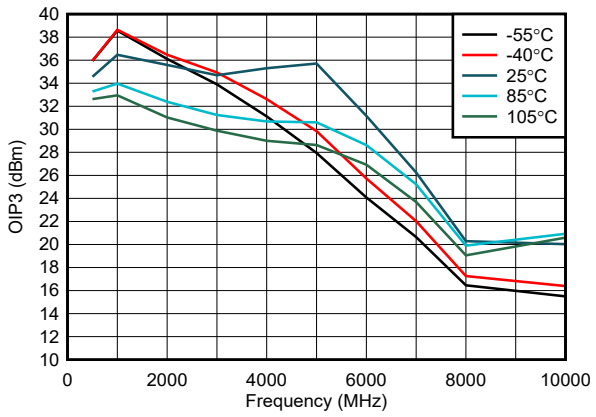


Figure 5-6. Reverse Isolation Across V_{DD}

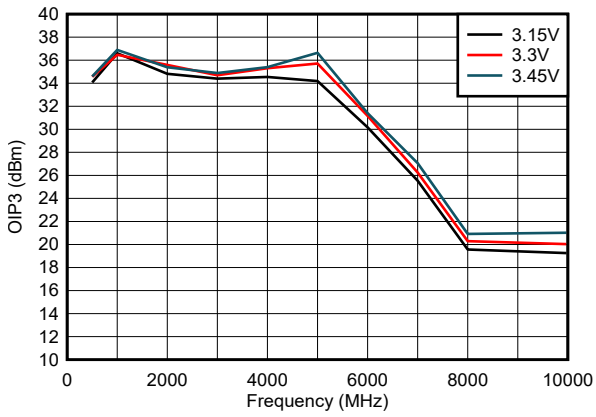
5.6 Typical Characteristics (continued)

at T_A = 25°C, temperature curves specify ambient temperature, V_{DD} = 3.3V, 50Ω single-ended input, and 100Ω differential output (unless otherwise noted)



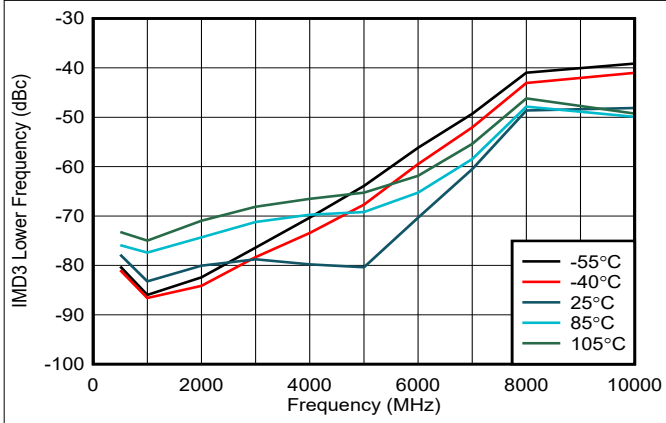
P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-7. OIP3 Across Temperature



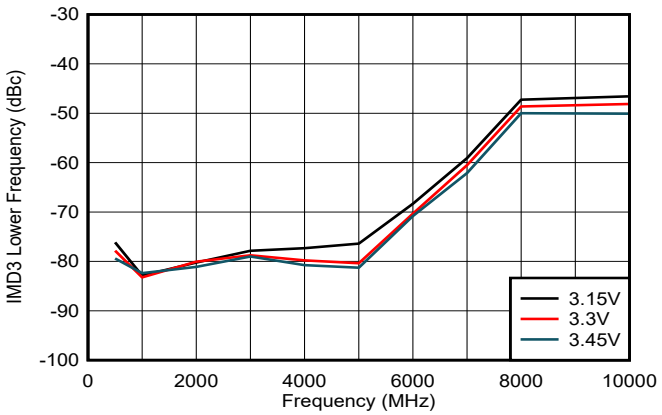
P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-8. OIP3 Across V_{DD}



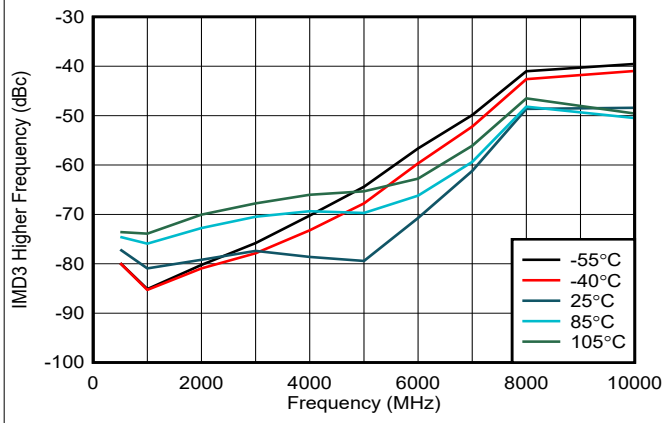
At ($2f_1 – f_2$) frequency, $f_1 < f_2$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-9. IMD3 Lower Across Temperature



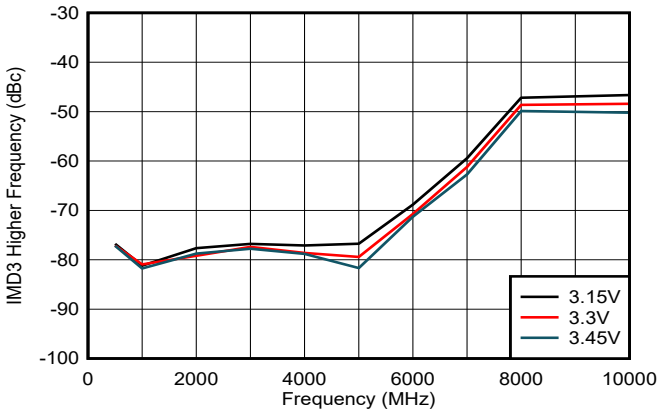
At ($2f_1 – f_2$) frequency, $f_1 < f_2$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-10. IMD3 Lower Across V_{DD}



At ($2f_2 – f_1$) frequency, $f_1 < f_2$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-11. IMD3 Higher Across Temperature

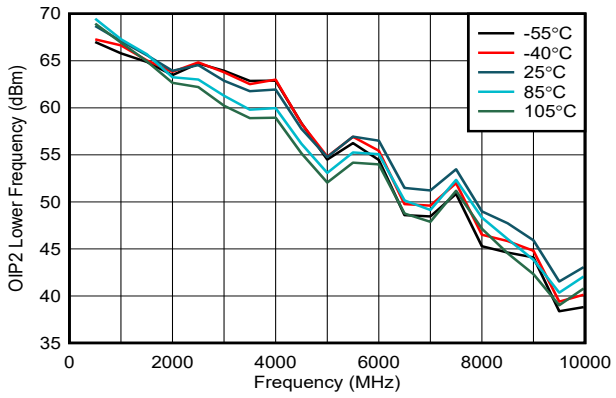


At ($2f_2 – f_1$) frequency, $f_1 < f_2$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-12. IMD3 Higher Across V_{DD}

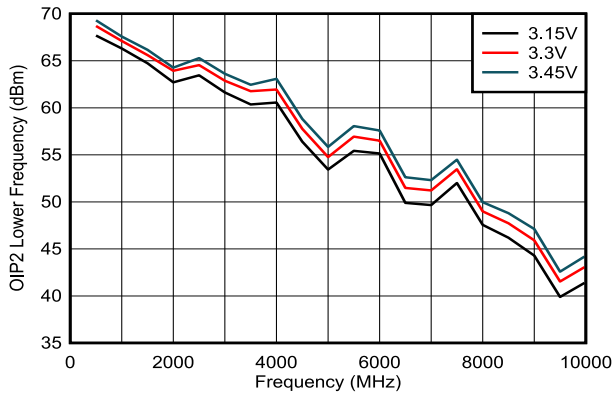
5.6 Typical Characteristics (continued)

at T_A = 25°C, temperature curves specify ambient temperature, V_{DD} = 3.3V, 50Ω single-ended input, and 100Ω differential output (unless otherwise noted)



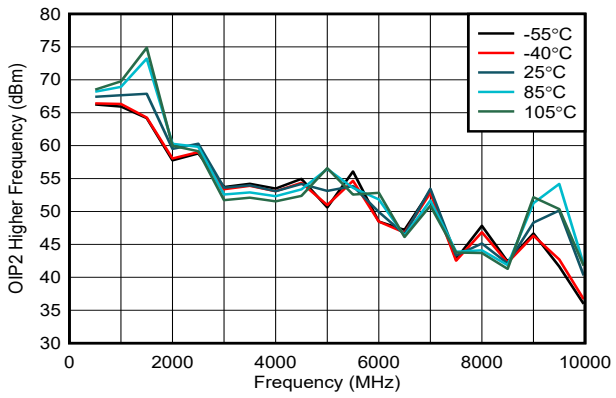
At ($f_2 - f_1$) frequency, $f_2 > f_1$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-13. OIP2 Lower Across Temperature



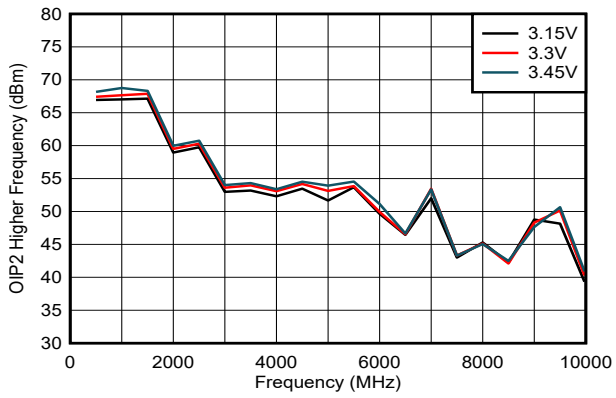
At ($f_2 - f_1$) frequency, $f_2 > f_1$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-14. OIP2 Lower Across V_{DD}



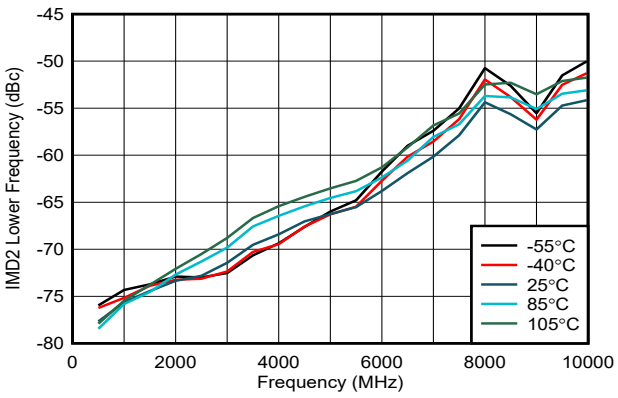
At ($f_2 + f_1$) frequency, $f_2 > f_1$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-15. OIP2 Higher Across Temperature



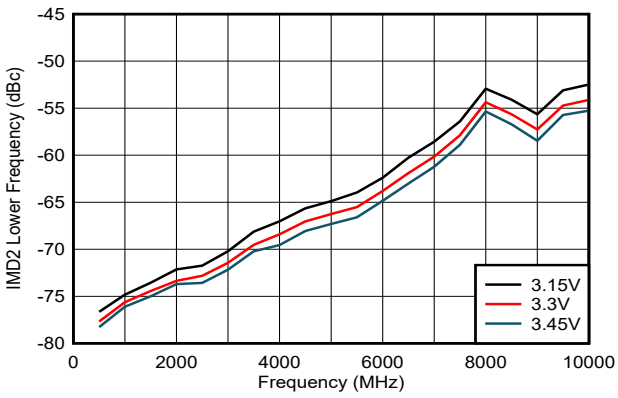
At ($f_2 + f_1$) frequency, $f_2 > f_1$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-16. OIP2 Higher Across V_{DD}



At ($f_2 - f_1$) frequency, $f_2 > f_1$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-17. IMD2 Lower Across Temperature

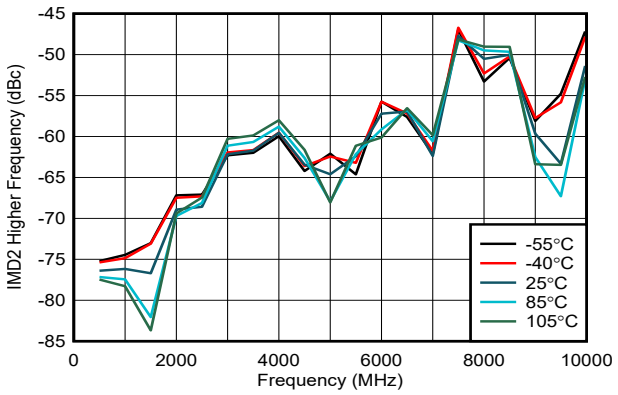


At ($f_2 - f_1$) frequency, $f_2 > f_1$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-18. IMD2 Lower Across V_{DD}

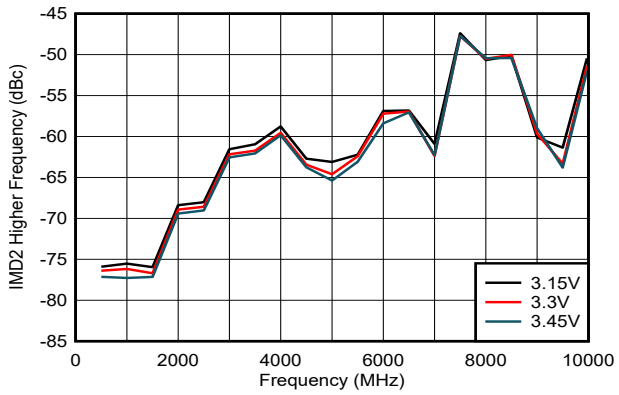
5.6 Typical Characteristics (continued)

at T_A = 25°C, temperature curves specify ambient temperature, V_{DD} = 3.3V, 50Ω single-ended input, and 100Ω differential output (unless otherwise noted)



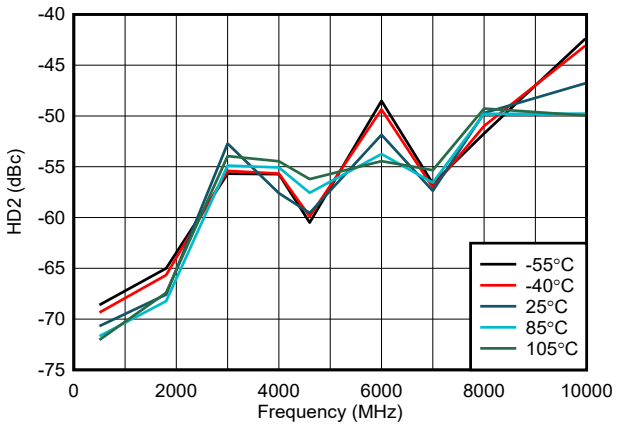
At ($f_2 + f_1$) frequency, $f_2 > f_1$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-19. IMD2 Higher Across Temperature



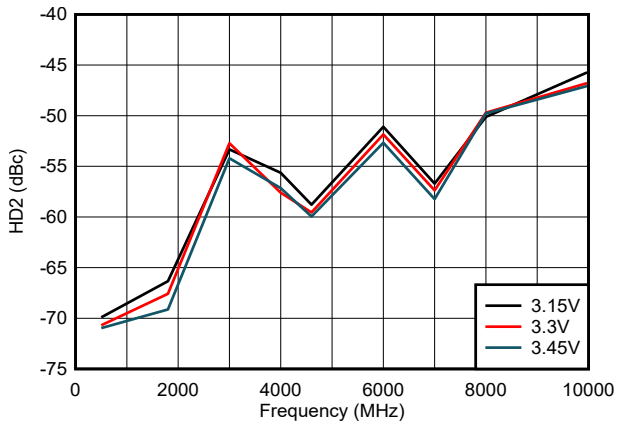
At ($f_2 + f_1$) frequency, $f_2 > f_1$; P_O/tone = –4dBm, 10MHz tone spacing

Figure 5-20. IMD2 Higher Across V_{DD}



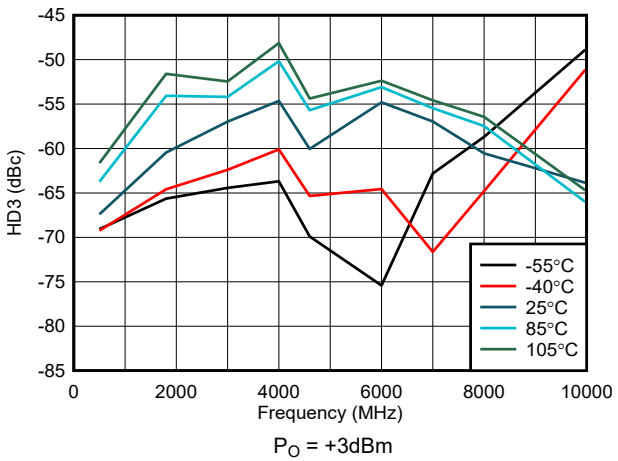
P_O = +3dBm

Figure 5-21. HD2 Across Temperature



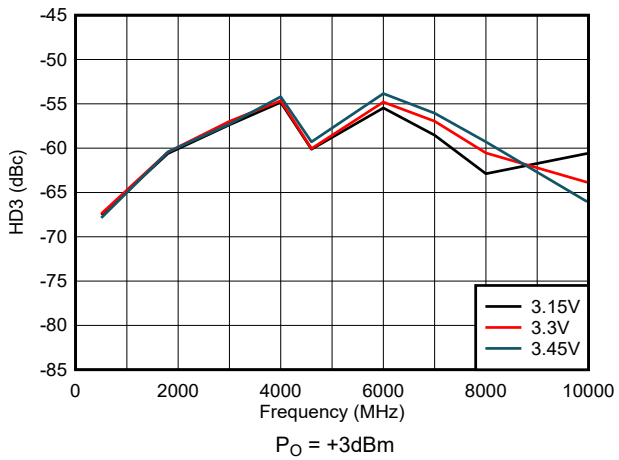
P_O = +3dBm

Figure 5-22. HD2 Across V_{DD}



P_O = +3dBm

Figure 5-23. HD3 Across Temperature



P_O = +3dBm

Figure 5-24. HD3 Across V_{DD}

5.6 Typical Characteristics (continued)

at T_A = 25°C, temperature curves specify ambient temperature, V_{DD} = 3.3V, 50Ω single-ended input, and 100Ω differential output (unless otherwise noted)

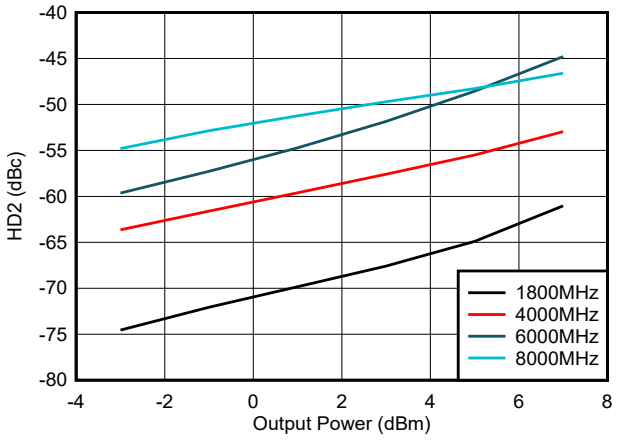


Figure 5-25. HD2 vs Output Power

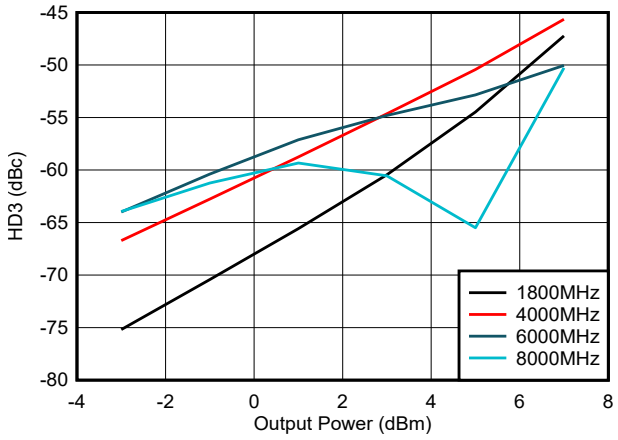


Figure 5-26. HD3 vs Output Power

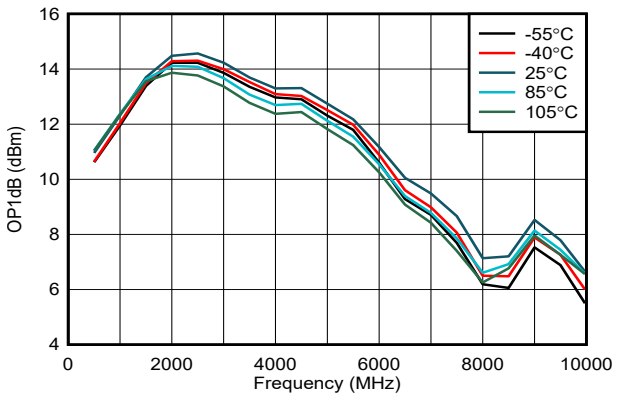


Figure 5-27. Output P1dB Across Temperature

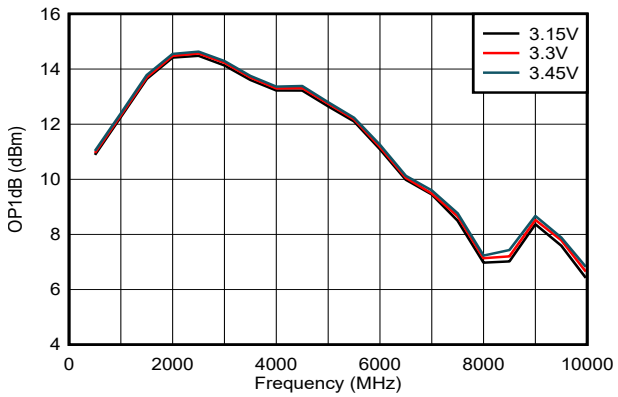


Figure 5-28. Output P1dB Across V_{DD}

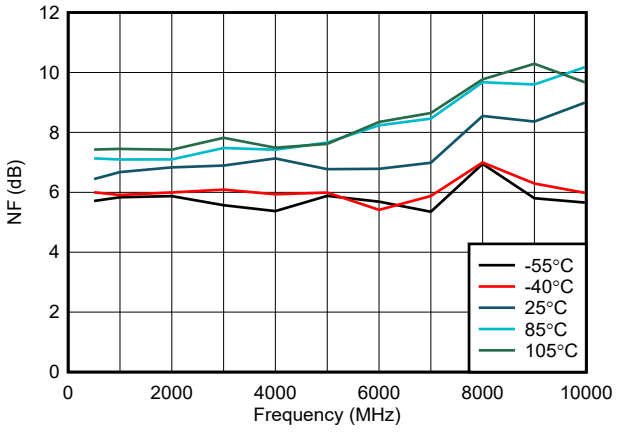


Figure 5-29. NF Across Temperature

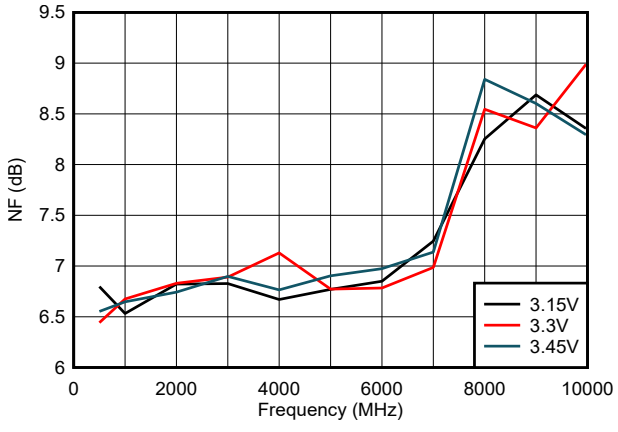


Figure 5-30. NF Across V_{DD}

5.6 Typical Characteristics (continued)

at T_A = 25°C, temperature curves specify ambient temperature, V_{DD} = 3.3V, 50Ω single-ended input, and 100Ω differential output (unless otherwise noted)

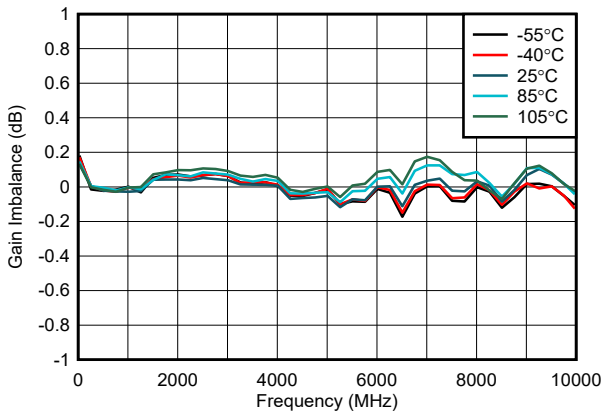


Figure 5-31. Gain Imbalance

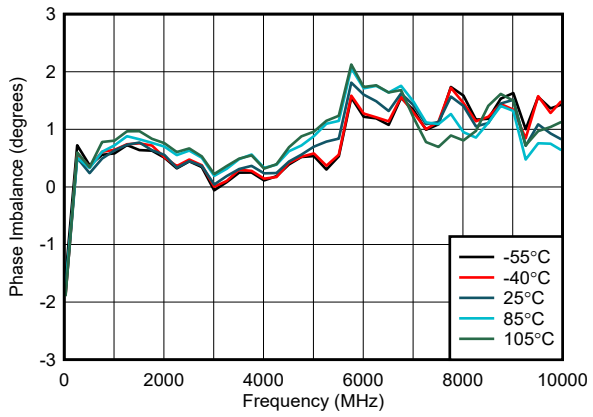


Figure 5-32. Phase Imbalance

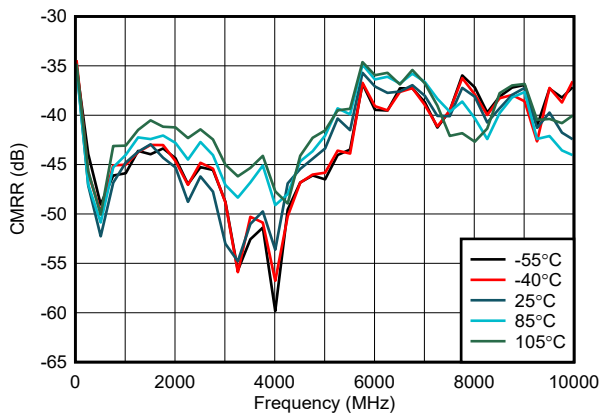


Figure 5-33. CMRR Across Temperature

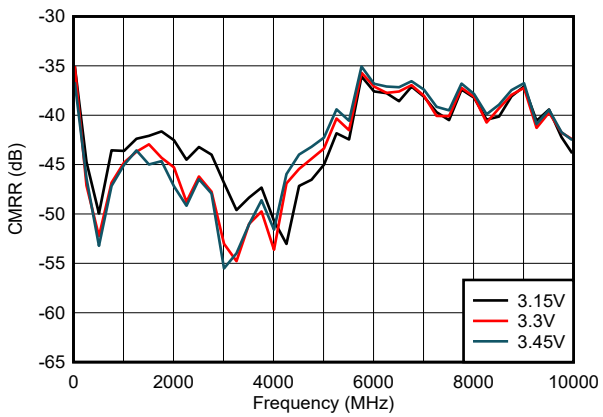
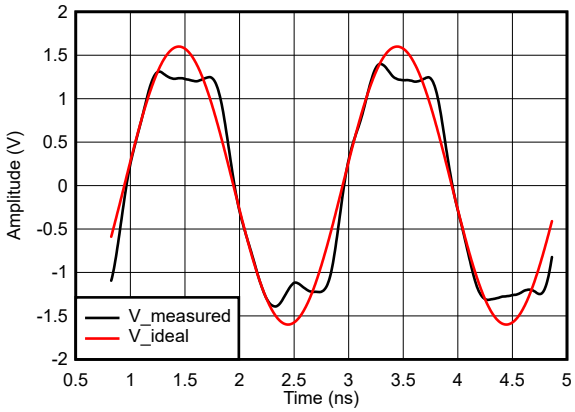
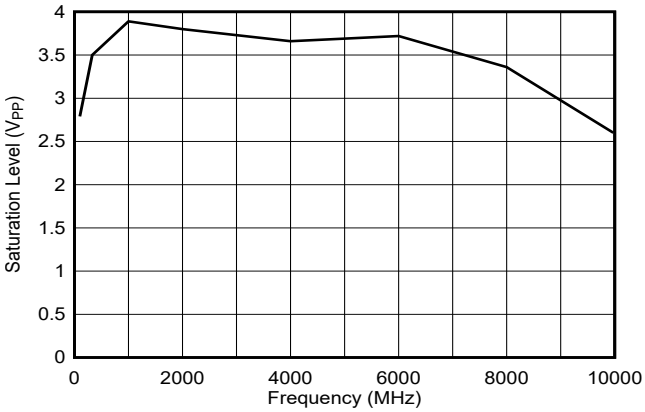


Figure 5-34. CMRR Across V_{DD}



Input = –2dBm, f = 500MHz

Figure 5-35. Overdrive Recovery

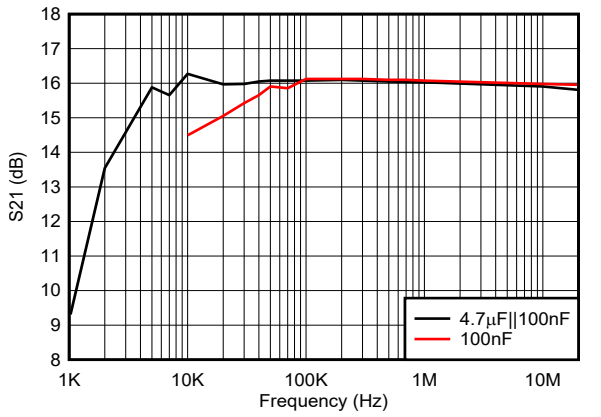


Input = +6dBm

Figure 5-36. Saturation Voltage (Differential)

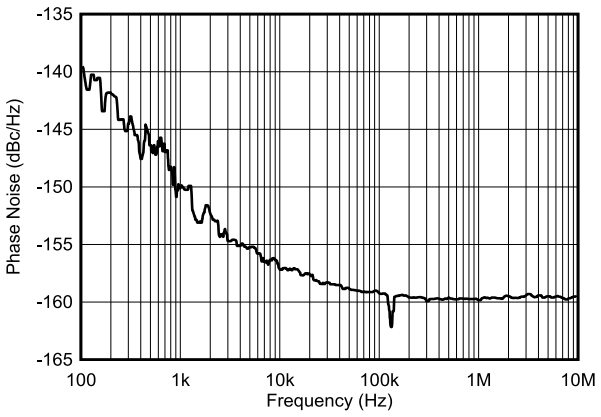
5.6 Typical Characteristics (continued)

at T_A = 25°C, temperature curves specify ambient temperature, V_{DD} = 3.3V, 50Ω single-ended input, and 100Ω differential output (unless otherwise noted)



Low-frequency cutoff as a function of ac-coupling capacitor

Figure 5-37. Low Frequency Gain Response



f = 1GHz, P_{IN} = –10dBm

Figure 5-38. Additive (Residual) Phase Noise

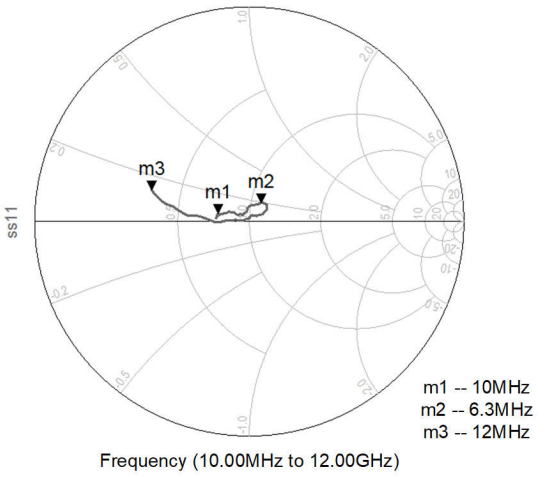


Figure 5-39. Single-Ended S11

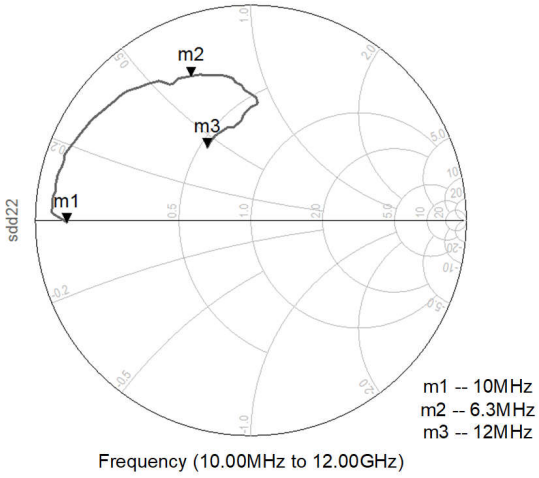


Figure 5-40. Differential S22

6 Detailed Description

6.1 Overview

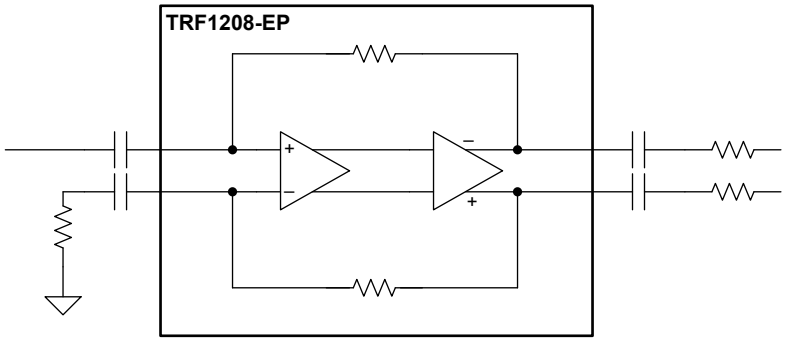
The TRF1208-EP is a very high-performance amplifier optimized for radio frequency (RF) and intermediate frequency (IF) with signal bandwidths up to 11GHz. The device is designed for ac-coupled applications that require a single-ended-to-differential conversion when driving an analog-to-digital converter (ADC). The low frequency response is limited only by the ac-coupling capacitor on the PCB. If the lowest signal frequency is >100KHz, use 100nF ac-coupling capacitors. If the lowest signal frequency is 9kHz, use a 4.7µF capacitor in parallel with 100nF capacitor on each input-output pin. The device has a two-stage architecture and provides approximately 16dB of gain in single-ended-to-differential mode, when driving a differential 100Ω load for single-ended inputs driven from a 50Ω source. This device also works as a fully-differential amplifier.

This device does not require any pullup or pulldown components on the PCB, and thereby simplifies the layout and provides the highest performance over the entire bandwidth.

The input and output are ac coupled. The TRF1208-EP is powered with 3.3V supply. A power-down feature is also available.

6.2 Functional Block Diagram

The following figure shows the functional block diagram of TRF1208-EP. The device essentially has two stages with a voltage-feedback configuration.



6.3 Feature Description

6.3.1 Fully-Differential Amplifier

The TRF1208-EP is a voltage-feedback fully differential amplifier (FDA) with a fixed gain by architecture. The TRF1208-EP operates as a single-ended to differential amplifier by terminating the INM pin with a 50Ω resistor and driving the INP pin directly with no external components.

This amplifier has nonlinearity cancellation circuits that provide excellent linearity performance over a wide range of frequencies.

The output of the amplifier has a low dc impedance. Therefore, if required, match the output of the amplifier to a load by adding the appropriate series resistors or attenuator pad.

6.3.2 Single Supply Operation

The TRF1208-EP operates on a single 3.3V supply. The input and output bias voltages are set internally. Therefore, ac-couple the signal path on the board at all four RF input and output pins. Single-supply operation simplifies the board design.

6.4 Device Functional Modes

TRF1208-EP has two functional modes: active and power-down. The functional modes are controlled by the PD pin as described below.

6.4.1 Power Down Mode

The device features a power-down option. The PD pin is used to power down the amplifier. This pin supports both 1.8V and 3.3V digital logic, and is referenced to ground. A logic 1 turns the device off and places the device into a low-quiescent-current state.

When disabled, the signal path is still present through the internal circuits. Input signals applied to a disabled device still appear at the outputs at a lower level through this path, as is the case for any disabled feedback amplifier.

7 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Application Information

7.1.1 Driving a High-Speed ADC

A common application for the TRF1208-EP is driving a high-speed ADC that has a differential input (such as the ADC12DJ5200-EP or AFE7950-EP). Conventionally passive baluns are used to drive giga-samples-per-second (GSPS) ADCs as a result of the low availability of high-bandwidth, linear amplifiers. The TRF1208-EP is typically configured as a single-ended to differential (S2D) RF amplifier that has excellent bandwidth flatness, gain, and phase imbalance comparable to or exceeding costly passive RF baluns.

Figure 7-1 shows a typical interface circuit for ADC12DJ5200-EP. Depending on the ADC and system requirement, simplify this circuit or make this circuit more complex.

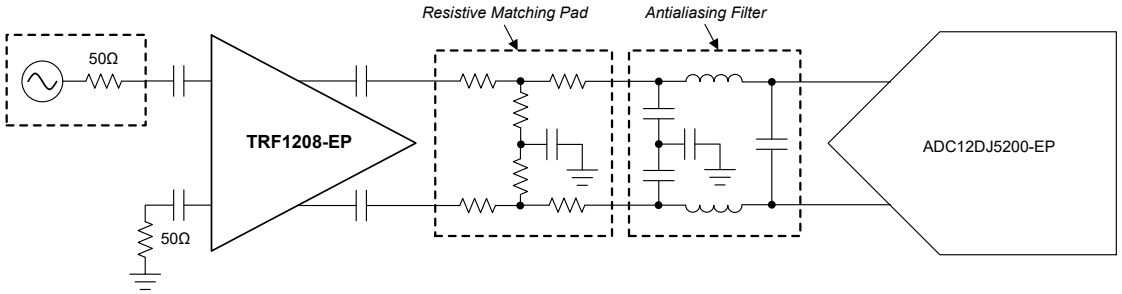
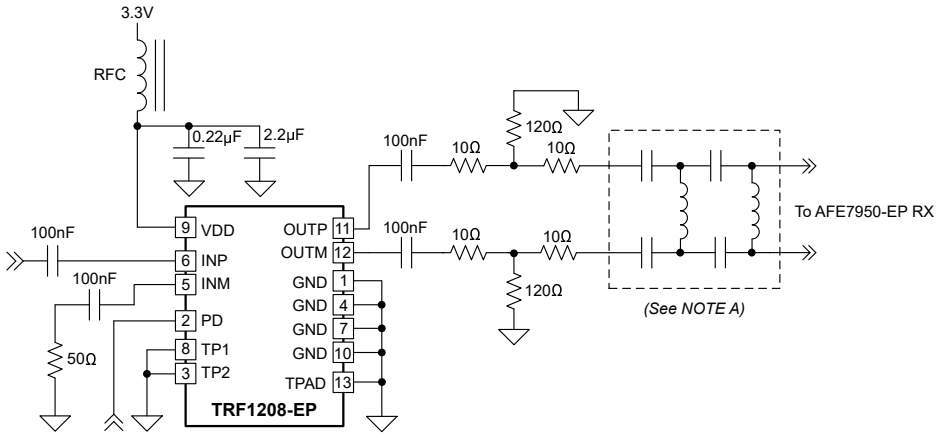


Figure 7-1. Interfacing With the ADC12DJ5200-EP

Figure 7-1 shows two sections of the circuit between the driver amp and the ADC: namely, the matching pad (or attenuator pad) and the antialiasing filter. Use small-form-factor, RF-quality, passive components for these circuits. The output swing of the TRF1208-EP is designed to drive these ADCs full-scale, while at the same time not overdrive the ADC. This functionality avoids the need for any voltage limiting device at the ADC.

Figure 7-2 shows a typical interface circuit for the AFE7950-EP, where the TRF1208-EP is the S2D amplifier.



A. AFE matching network – component type (L or C) and values depend on channel (A, B, C, D, FB1, and FB2) and frequency band.

Figure 7-2. Interfacing With the AFE7950-EP

7.1.2 Calculating Output Voltage Swing

This section gives a quick reference of the output voltage swings for different input power levels. In this example, the output is terminated with a 100Ω differential load and a power gain of 16dB is assumed.

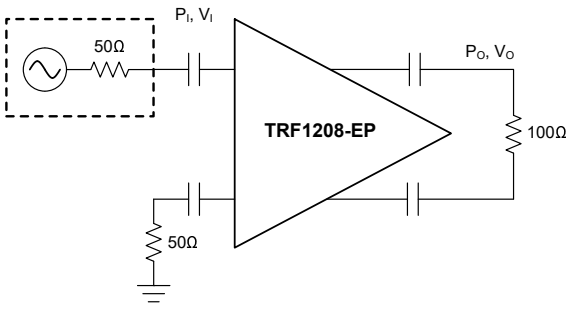


Figure 7-3. Power and Voltage Levels

$$\text{Voltage gain} = 20 \times \log(V_O / V_I) \quad (1)$$

$$\text{Power gain} = 10 \times \log(P_O / P_I) = 10 \times \log((V_O{}^2 / 100) / (V_I{}^2 / 50)) = 20 \times \log(V_O / V_I) - 3\text{dB} \quad (2)$$

Table 7-1. Output Voltage Swings for Different Input Power Levels

INPUT		OUTPUT (TRF1208-EP)	
P_I (dBm_{50})	V_I (V_{PP})	P_O (dBm_{100})	V_O (V_{PP})
–20	0.063	–4	0.564
–15	0.112	1	1.004
–10	0.2	6	1.785
–9	0.224	7	2.002

7.1.3 Thermal Considerations

The TRF1208-EP is available in a 2mm × 2mm, WQFN-FCRLF package that has excellent thermal properties. Connect the thermal pad underneath the chip to a ground plane. Short the ground plane to the other ground pins of the chip at four corners, if possible, to allow heat propagation to the top layer of PCB. Use a thermal via that connects the thermal pad plane on the top layer of the PCB to the inner layer ground planes to allow heat propagation to the inner layers.

7.2 Typical Applications

An example of the TRF1208-EP acting as an S2D amplifier for the AFE7950-EP is explained in this section.

7.2.1 TRF1208-EP in Receive Chain

This section describes an RF receiver chain in which the TRF1208-EP operates as a single-ended-to-differential (S2D) amplifier and drives a receive channel of AFE7950-EP.

Figure 7-4 shows a generic schematic of a design in which TRF1208-EP drives an AFE7950-EP receive channel. The exact values of the components depend on the frequency band for which the AFE7950-EP front-end is matched.

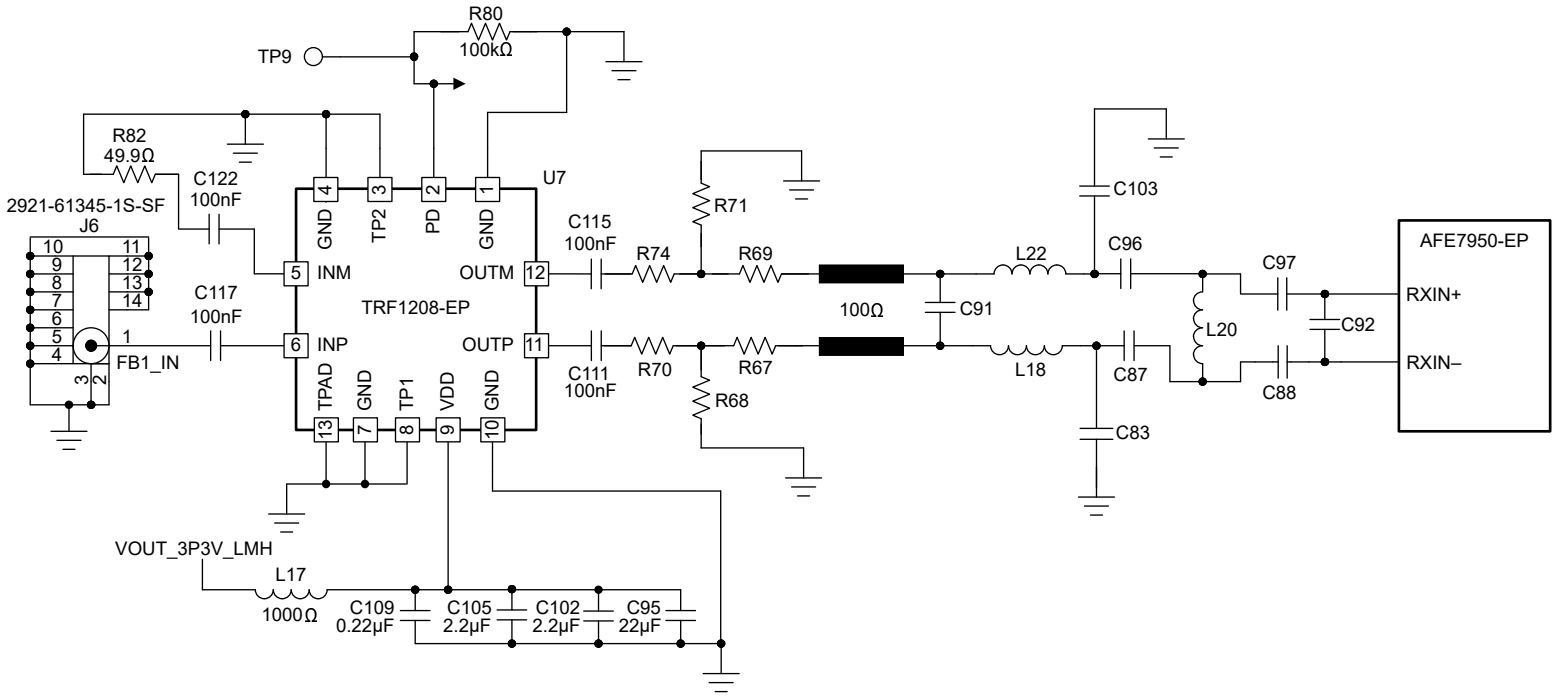


Figure 7-4. TRF1208-EP in a Receive Chain With the AFE7950-EP

7.2.1.1 Design Requirements

The AFE7950-EP channel is required to be matched to 2.3GHz.

7.2.1.2 Detailed Design Procedure

The TRF1208-EP is configured as an S2D amplifier. The section close to TRF1208-EP output is an attenuator pad that is meant for robust matching. The section close to the AFE7950-EP is the matching network for the AFE7950-EP ADC input that is channel dependent. The matching components are chosen based on the AFE7950-EP return-loss data and some final optimization because the manufactured board parameters potentially influence the exact component values needed.

Table 7-2 shows the bill of materials (BOM) values of the design for RXA channel that is matched to center frequency of 2.3GHz.

Table 7-2. Component Values of RX Chain With Center Frequency = 2.3GHz

SECTION	DESIGNATOR	TYPE	VALUE	INSTALL OR DO NOT INSTALL
DC block cap	C117	Capacitor	100nF	Install
DC block cap	C115	Capacitor	100nF	Install
DC block cap	C111	Capacitor	100nF	Install
DC block cap	C122	Capacitor	100nF	Install
INM term	R82	Resistor	50Ω	Install
Attenuator	R74	Resistor	10Ω	Install
Attenuator	R70	Resistor	10Ω	Install
Attenuator	R69	Resistor	10Ω	Install
Attenuator	R67	Resistor	10Ω	Install
Attenuator	R71	Resistor	120Ω	Install
Attenuator	R68	Resistor	120Ω	Install
Matching	C91	—	—	Do not install
Matching	C103	—	—	Do not install
Matching	C83	—	—	Do not install
Matching	L22	Inductor	0.1nH	Install
Matching	L18	Inductor	0.1nH	Install
Matching	C96	Inductor	0.1nH	Install
Matching	C87	Inductor	0.1nH	Install
Matching	L20	Inductor	5.6nH	Install
Matching	C97	Capacitor	3.9pF	Install
Matching	C88	Capacitor	3.9pF	Install
Matching	C92	—	—	Do not install

7.2.1.3 Application Curve

Figure 7-5 shows the in-band output response for the design in the previous section. The response is measured with an input power of –30dBm at the input of TRF1208-EP.

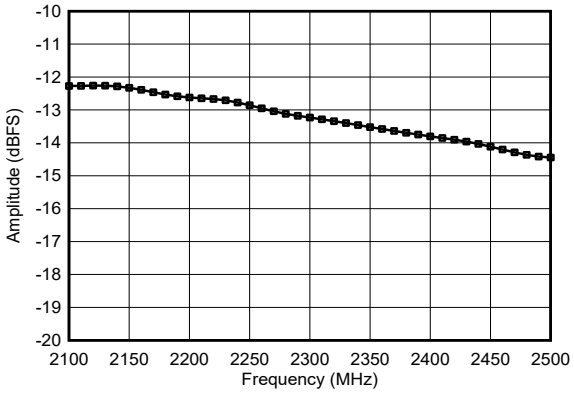


Figure 7-5. In-Band Output Response

7.3 Power Supply Recommendations

The TRF1208-EP requires a single 3.3V supply. Supply decoupling is critical to high-frequency performance. Typically two or three capacitors are used for supply decoupling. For the lowest-value capacitor, use a small, form-factor component that is placed closest to the V_{DD} pin of the device. Use a bulk decoupling capacitor of a larger value and size that fits next to the small capacitor. See also Section 7.4.

7.4 Layout

7.4.1 Layout Guidelines

TRF1208-EP is a wide-band, voltage-feedback amplifier with approximately 16dB of gain. When designing with a wide-band RF amplifier with relatively high gain, take precautions with board layout to maintain stability and optimized performance. Use a multilayer board to maintain signal and power integrity and thermal performance. Figure 7-6 shows an example of a good layout. This figure shows only the top layer.

Route the RF input and output lines as grounded coplanar waveguide (GCPW) lines. For the second layer, use a continuous ground layer without any ground-cuts near the amplifier area. Match the output differential lines in length to minimize phase imbalance. Use small-footprint passive components wherever possible. Also take care of the input side layout. Use a 50Ω line for the INP routing, and ensure that the termination on INM pin has low parasitics by placing the ac-coupling capacitor and the 50Ω resistor very close to the device. Use an RF-quality, 50Ω resistor for termination. Ensure that the ground planes on the top and internal layers are well stitched with vias.

Place thermal vias under the device that connect the top thermal pad with ground planes in the inner layers of the PCB. For improved heat dissipation, connect the thermal pad to the top-layer ground plane through the ground pins (see also Section 7.4.2).

7.4.2 Layout Example

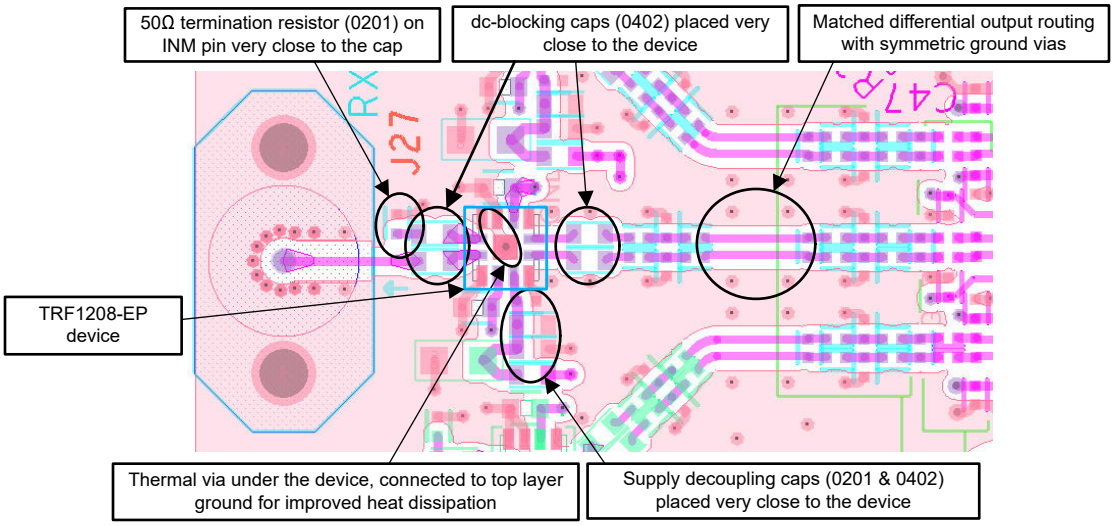


Figure 7-6. Layout Example: Placement and Top Layer Layout

Evaluate the TRF1208-EP device using the TRF1208EVM board. Additional information about the evaluation board construction and test setup is given in the *TRF1208EVM* user's guide.

8 Device and Documentation Support

8.1 Device Support

8.1.1 Third-Party Products Disclaimer

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8.2 Documentation Support

8.2.1 Related Documentation

8.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.4 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

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8.6 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.7 Glossary

TI Glossary	This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
August 2025	*	Initial Release

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TRF1208RPVTNEPG4	Active	Production	WQFN-HR (RPV) | 12	250 | SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	208E
V62/25645-01XE	Active	Production	WQFN-HR (RPV) | 12	250 | SMALL T&R	-	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	208E

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

OTHER QUALIFIED VERSIONS OF TRF1208-EP :

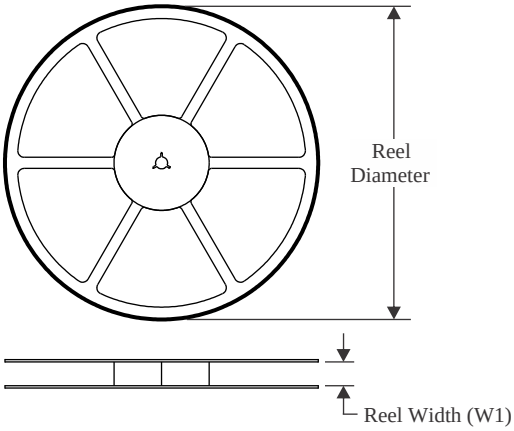
- Catalog : TRF1208

NOTE: Qualified Version Definitions:

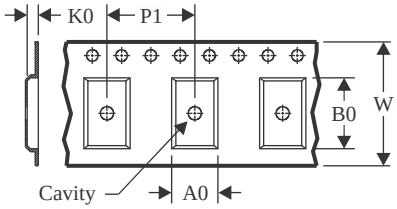
- Catalog - TI's standard catalog product

TAPE AND REEL INFORMATION

REEL DIMENSIONS

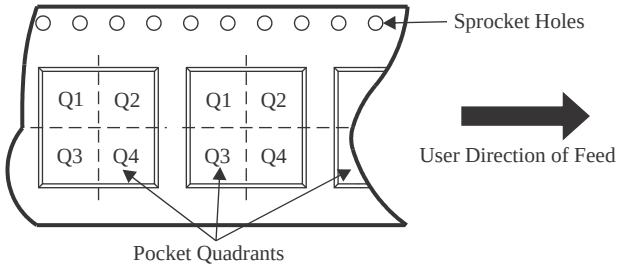


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

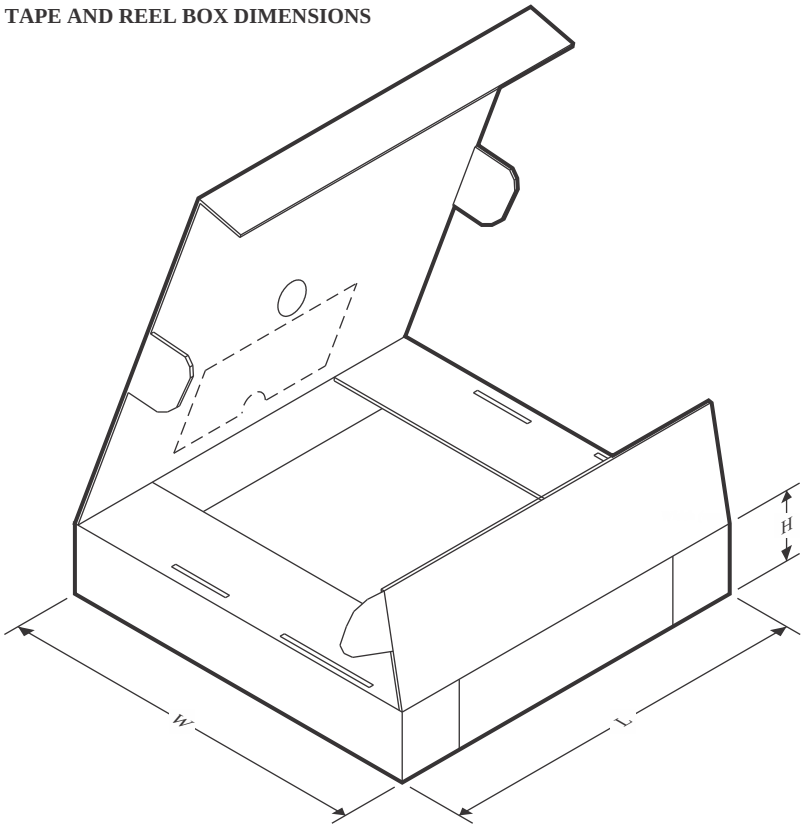
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TRF1208RPVTNEPG4	WQFN-HR	RPV	12	250	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

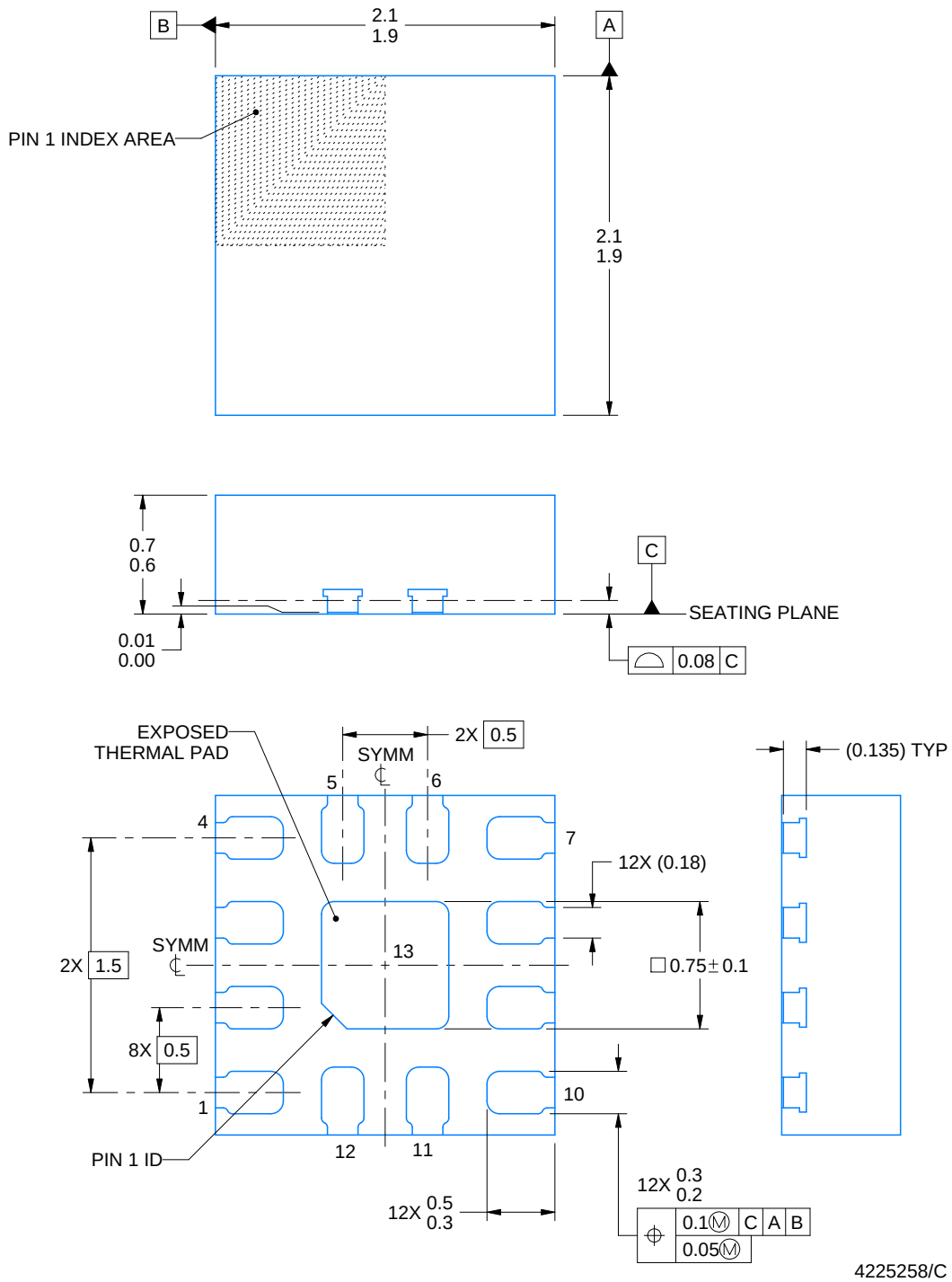
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TRF1208RPVTNEPG4	WQFN-HR	RPV	12	250	210.0	185.0	35.0

PACKAGE OUTLINE

RPV0012A

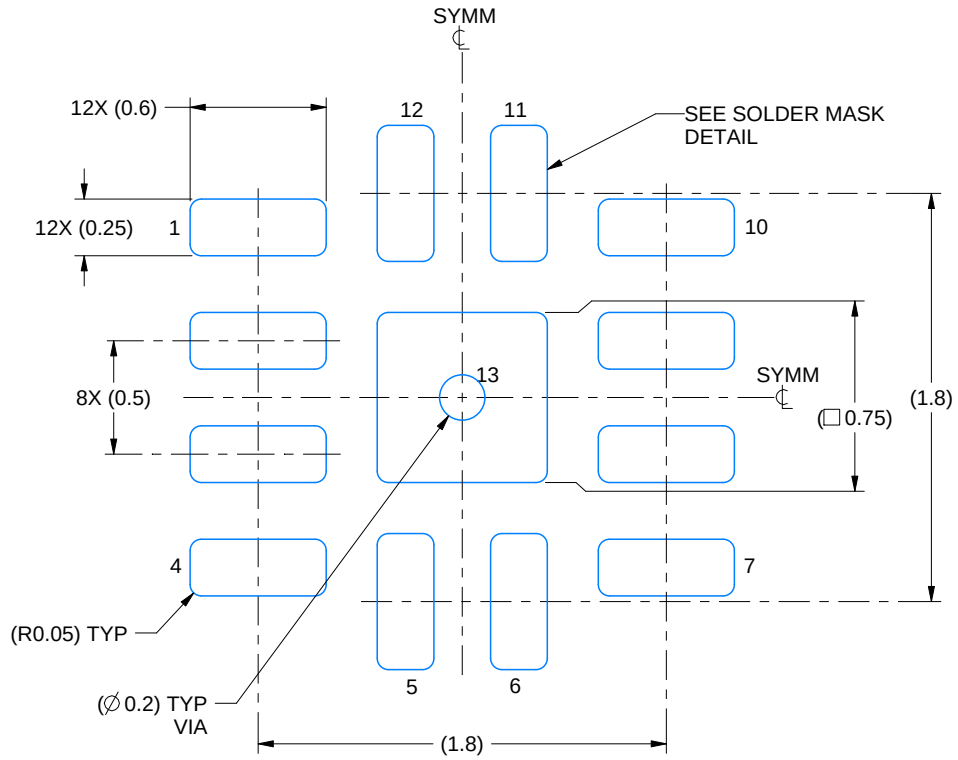
WQFN-FCRLF - 0.7 mm max height

PLASTIC QUAD FLATPACK - NO LEAD

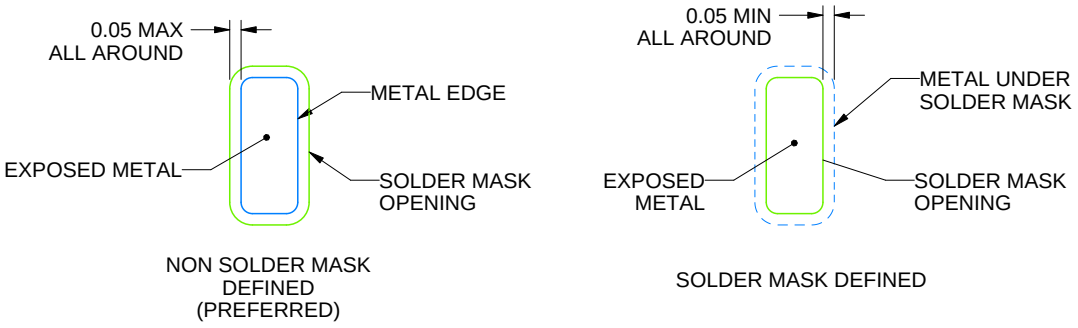


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 30X



SOLDER MASK DETAILS

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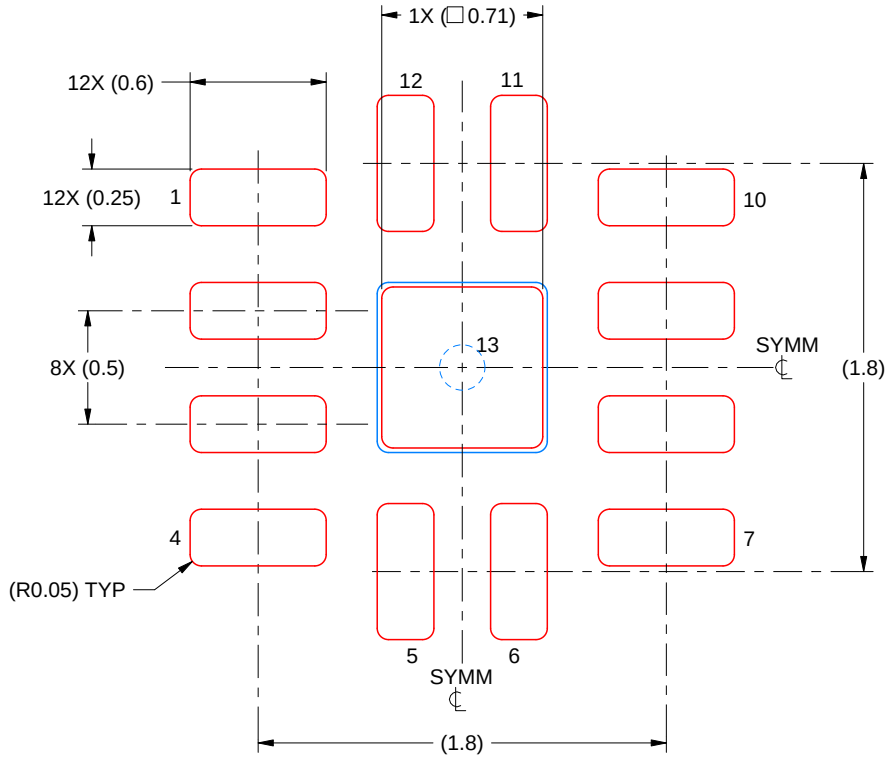
NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 30X

EXPOSED PAD 13
90% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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